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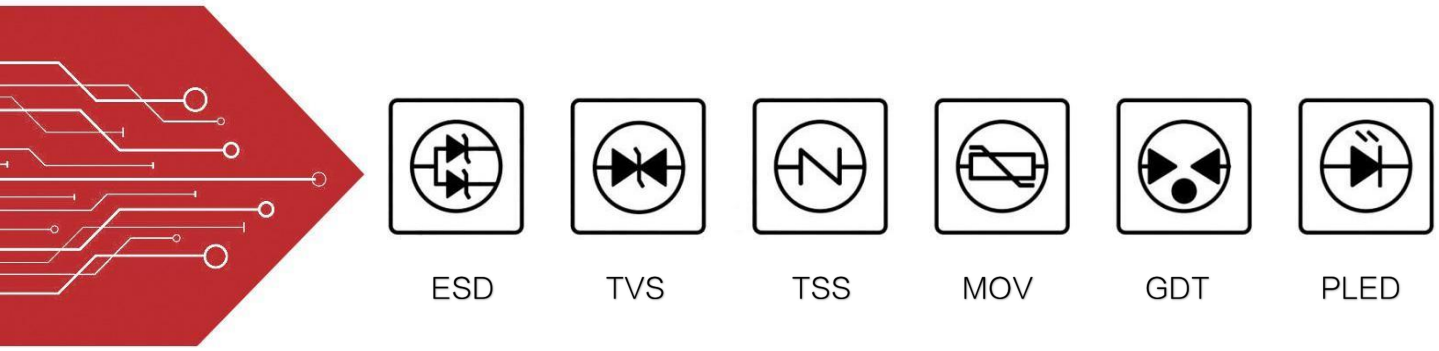
SEMICONDUCTOR

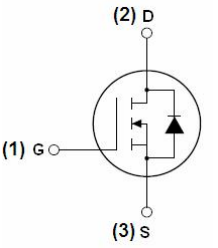


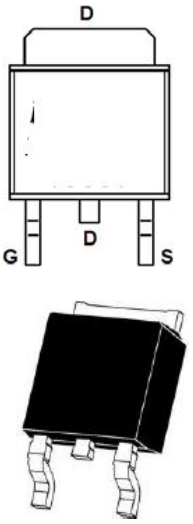
Product data sheet

Product Summary

- V_{DS} 30V
- I_D 60A
- $R_{DS(ON)}$(at V_{GS}=10V) ＜9.0mohm
- $R_{DS(ON)}$(at V_{GS}=4.5V) ＜11.0mohm
- 100% UIS Tested
- 100% ▽V_{DS} Tested

Schematic diagram





TO-252

General Description

- Trench Power LV MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$

Applications

- High current load applications
- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply

■ Absolute Maximum Ratings (T_A=25℃unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		V_{DS}	30	V
Gate-source Voltage		V_{GS}	±20	V
Drain Current	T_C=25℃	I_D	60	A
	T_C=100℃		35	
Pulsed Drain Current [A]		I_{DM}	150	A
Total Power Dissipation	T_C=25℃	P_D	34	W
	T_C=100℃		17	W
Single Pulse Avalanche Energy [B]		E_{AS}	80	mJ
Thermal Resistance Junction-to-Case [C]		$R_{\theta JC}$	4.4	℃/W
Junction and Storage Temperature Range		T_J,T_{STG}	-55～+175	℃

■ Electrical Characteristics (T_J=25℃ unless otherwise noted)

Parameter	Symbol	Conditions		Min	Typ	Max	Units
Static Parameter							
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}= 0V, I_D=250μA		30			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=30V,V_{GS}=0V	T_J=25℃			1	μA
			T_J=55℃			5	
Gate-Body Leakage Current	I_{GSS}	V_{GS}= ±20V, V_{DS}=0V				±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}= V_{GS}, I_D=250μA		1.0	1.5	2.5	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	V_{GS}= 10V, I_D=15A			6.5	9.0	mΩ
		V_{GS}= 4.5V, I_D=15A			8.6	11.0	
Diode Forward Voltage	V_{SD}	I_S=15A,V_{GS}=0V			0.85	1.2	V
Maximum Body-Diode Continuous Current	I_S					50	A
Dynamic Parameters							
Input Capacitance	C_{iss}	V_{DS}=15V,V_{GS}=0V,f=1MHZ			920		pF
Output Capacitance	C_{oss}				198		
Reverse Transfer Capacitance	C_{rss}				114		
Switching Parameters							
Total Gate Charge	Q_g	V_{GS}=10V,V_{DS}=15V,I_D=50A			28		nC
Gate-Source Charge	Q_{gs}				7		
Gate-Drain Charge	Q_{gd}				5		
Reverse Recovery Charge	Q_{rr}	I_F=20A, di/dt=100A/us			25		
Reverse Recovery Time	t_{rr}				26		ns
Turn-on Delay Time	$t_{D(on)}$	V_{GS}=10V,V_{DD}=20V, I_D=2A,R_L=1Ω R_{GEN}=3Ω			8		
Turn-on Rise Time	t_r				15		
Turn-off Delay Time	$t_{D(off)}$				27		
Turn-off fall Time	t_f				7		

A. Pulse Test: Pulse Width≤300us,Duty cycle ≤2%.

B. T_j=25℃, V_{DD}=20V, V_G=10V, L=0.5mH, R_g=25Ω

C. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.

■ Typical Performance Characteristics

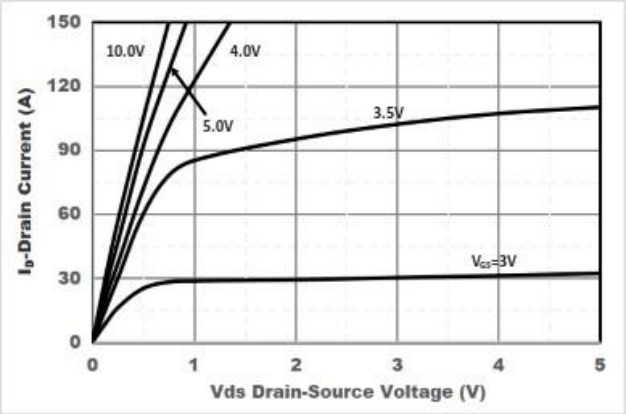


Figure1. Output Characteristics

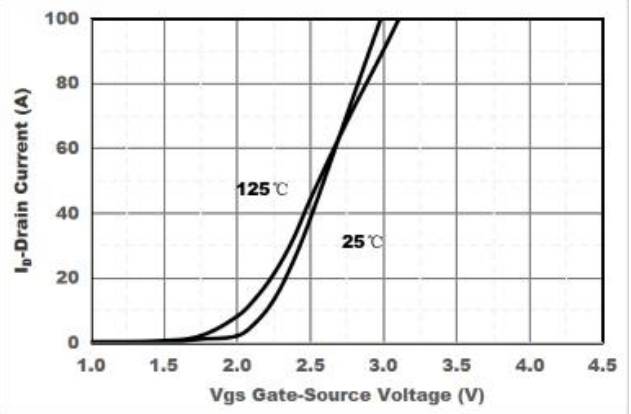


Figure2. Transfer Characteristics

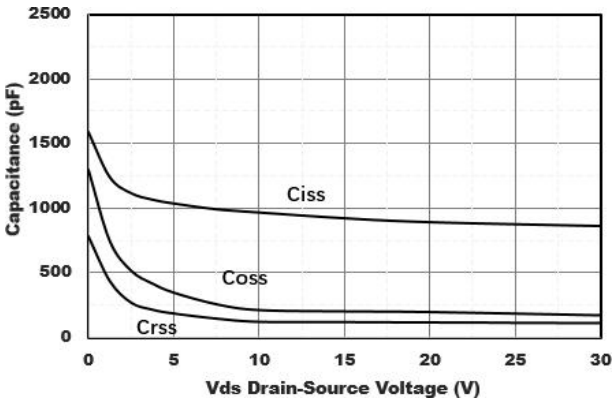


Figure3. Capacitance Characteristics

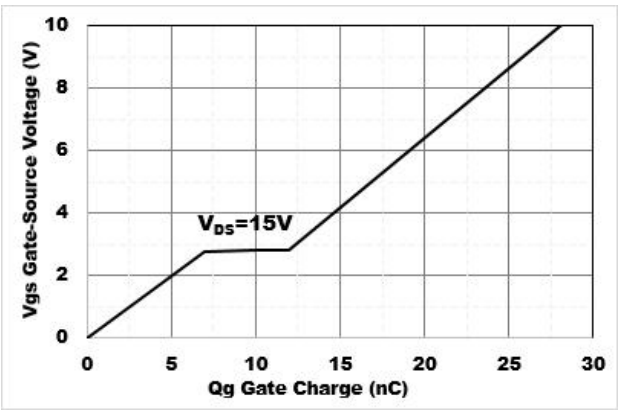


Figure4. Gate Charge

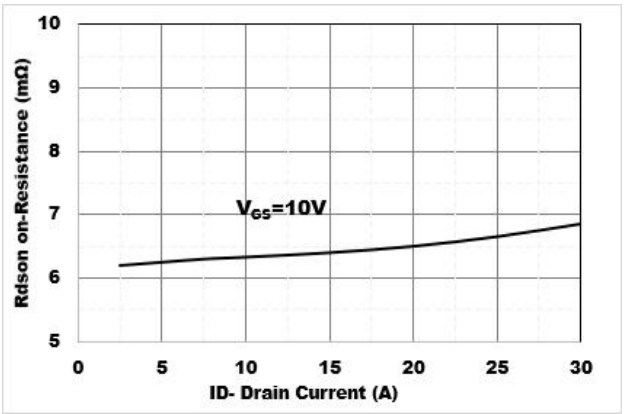


Figure5. Drain-Source on Resistance

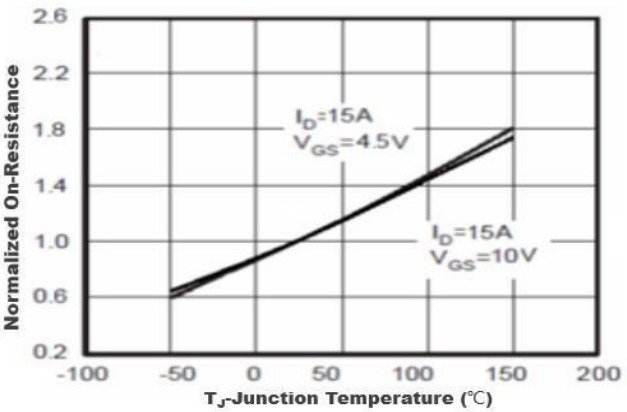


Figure6. Drain-Source on Resistance

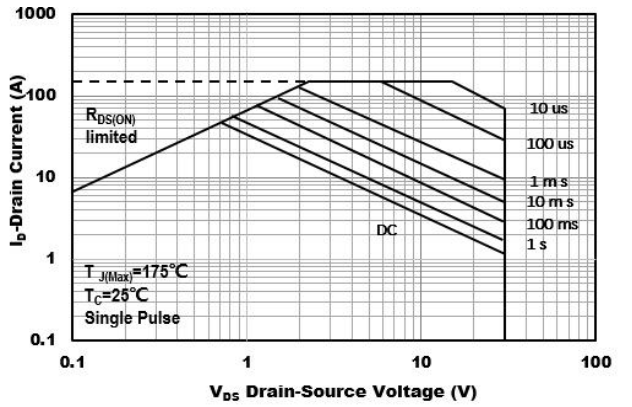


Figure7. Safe Operation Area

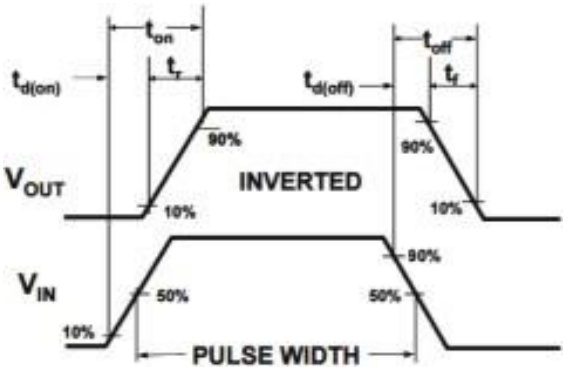
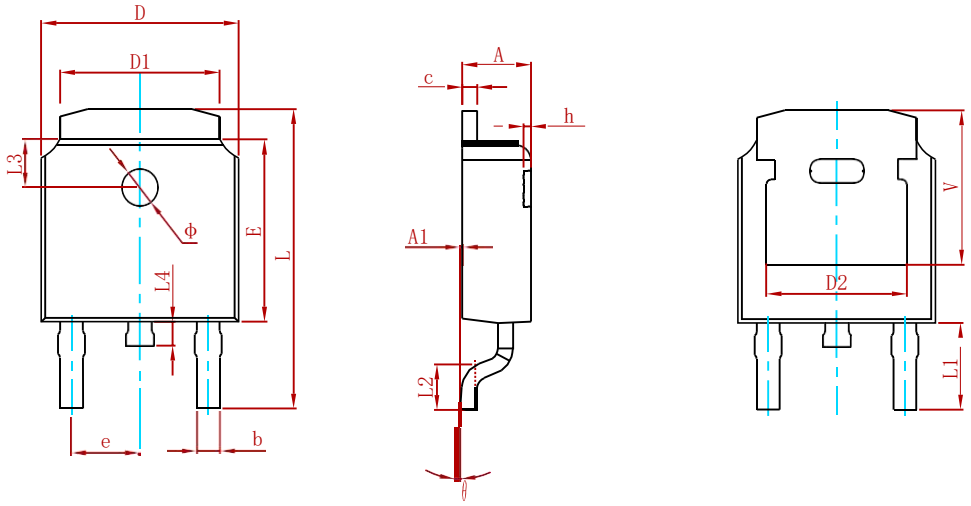


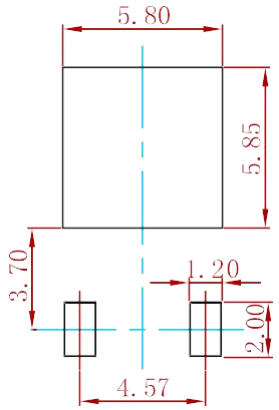
Figure8. Switching wave

PACKAGE MECHANICAL DATA



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250 REF.		0.207 REF.	

Suggested Pad Layout



Note:
1.Controlling dimension:in millimeters.
2.General tolerance:± 0.05mm.
3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
MS60N03	TO-252	2500

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